Acta Crystallographica Section E Structure Reports Online

ISSN 1600-5368

John M. Villegas, Stanislav R. Stoyanov, Curtis E. Moore, David M. Eichhorn and D. Paul Rillema*

Department of Chemistry, Wichita State University, Wichita, KS 67260, USA

Correspondence e-mail: paul.rillema@wichita.edu

Key indicators

Single-crystal X-ray study T = 100 KMean σ (C–C) = 0.005 Å R factor = 0.021 wR factor = 0.051 Data-to-parameter ratio = 12.8

For details of how these key indicators were automatically derived from the article, see http://journals.iucr.org/e.

fac-Tricarbonyl(2,9-dimethyl-1,10-phenanthroline)(2,6-dimethylphenyl isocyanide)rhenium(I) hexafluorophosphate

In the title compound, $[Re(C_9H_9N)(C_{14}H_{12}N_2)(CO)_3]PF_6$, the complex cation adopts a distorted octahedral geometry, with the Re atom at the center and a facial disposition of the three carbonyl ligands.

Received 10 December 2004 Accepted 10 February 2005 Online 19 February 2005

Comment

The title compound, (I), was synthesized as part of a series of diimine tricarbonylrhenium(I) complexes containing the ligand 2,6-dimethylphenyl isocyanide. These complexes are highly emissive. The emission lifetimes are in the microsecond timescale both at room temperature and at 77 K. These complexes have potential usage as dyes for solar energy conversion cells as well as sensors.



The cation (Fig. 1) shows distorted octahedral coordination, with the Re^I atom in the center and the three carbonyl ligands arranged so that the facial isomer is formed. The P–F distances in the anion are in the range 1.595 (3)–1.606 (3) Å.

Experimental

The title compound was prepared by modifying the procedure of Wrighton & Morse (1974). [Re(CO)₅Cl] (0.55 mmol) was added to an equimolar amount of 2,9-dimethyl-1,10-phenanthroline in a 125 ml round-bottomed flask. Absolute ethanol (50 ml) was added and the resulting mixture refluxed for 2–4 h. A light-yellow precipitate of [ReCl(C₁₄H₁₂N₂)(CO)₃] was formed. The solution was cooled to room temperature and filtered. The solid obtained was dried in a vacuum oven. Following the procedure of Shaver & Rillema (1992), the solid was combined with AgCF₃SO₃ in a 1:1 ratio in ethanol. The mixture was refluxed for 4–6 h, resulting in the precipitation of AgCl and the formation of a CF₃SO₃⁻ salt. The solution was allowed to cool to room temperature and the AgCl was removed by filtration. The solution was added to an equimolar amount of 2,6-dimethyl-phenyl isocyanide and refluxed for another 3–5 h. The solvent was

© 2005 International Union of Crystallography Printed in Great Britain – all rights reserved

metal-organic papers



Figure 1

View of the title compound (50% probability displacement ellipsoids). H atoms have been omitted for clarity.

reduced in volume under vacuum. Saturated aqueous NH_4PF_6 (15 ml) was then added to the solution. The volume was diluted with distilled water to 50 ml (until precipitation was complete). The precipitate was filtered and dried in a vacuum oven. About 15 mg of the sample was dissolved in nitromethane (1 ml) in an uncovered small vial. The small vial was placed inside a larger vial containing diethyl ether. The vial was covered loosely and the solvent mixture was allowed to diffuse and slowly evaporate. Light-yellow crystals of the title compound were formed.

Crystal data

$[\text{Re}(\text{C}_{9}\text{H}_{9}\text{N})(\text{C}_{14}\text{H}_{12}\text{N}_{2})(\text{CO})_{3}]\text{PF}_{6}$
$M_r = 754.63$
Monoclinic, $P2_1/n$
a = 14.510 (4) Å
b = 11.223 (4) Å
c = 17.887 (5) Å
$\beta = 113.53 \ (2)^{\circ}$
$V = 2670.6 (14) \text{ Å}^3$
Z = 4

Data collection

Enraf-Nonius CAD-4 diffractometer Non-profiled $\omega/2\theta$ scans Absorption correction: refined from ΔF (Walker & Stuart, 1983) $T_{\min} = 0.198$, $T_{\max} = 0.245$ 4871 measured reflections 4682 independent reflections 3991 reflections with $I > 2\sigma(I)$ $D_x = 1.877 \text{ Mg m}^{-3}$ Mo K\alpha radiation Cell parameters from 24 reflections $\theta = 1-25^{\circ}$ $\mu = 4.69 \text{ mm}^{-1}$ T = 100 KPrism, yellow $0.5 \times 0.3 \times 0.3 \text{ mm}$

 $\begin{aligned} R_{\rm int} &= 0.026\\ \theta_{\rm max} &= 25.0^\circ\\ h &= 0 \rightarrow 17\\ k &= 0 \rightarrow 13\\ l &= -21 \rightarrow 19\\ 3 \text{ standard reflections}\\ \text{frequency: 60 min}\\ \text{intensity decay: none} \end{aligned}$

Refinement

Refinement on F^2	$w = 1/[\sigma^2(F_o^2) + (0.0226P)^2]$
$R[F^2 > 2\sigma(F^2)] = 0.021$	+ 4.1906P]
$vR(F^2) = 0.051$	where $P = (F_o^2 + 2F_c^2)/3$
S = 1.09	$(\Delta/\sigma)_{\rm max} = 0.002$
682 reflections	$\Delta \rho_{\rm max} = 0.57 \ {\rm e} \ {\rm \AA}^{-3}$
65 parameters	$\Delta \rho_{\rm min} = -0.60 \text{ e } \text{\AA}^{-3}$
H-atom parameters constrained	

 Table 1

 Selected geometric parameters (Å, °).

Re1-C2	1.920 (4)	Re1-N1	2.196 (3)
Re1-C1	1.994 (4)	Re1-N2	2.203 (3)
Re1-C4	2.063 (4)	N3-C4	1.152 (5)
C3-Re1-C2	84.56 (15)	C1-Re1-N1	92.21 (13)
C3-Re1-C1	90.93 (15)	C4-Re1-N1	87.48 (12)
C2-Re1-C1	95.39 (16)	C3-Re1-N2	101.03 (13)
C3-Re1-C4	89.12 (15)	C2-Re1-N2	169.88 (13)
C2-Re1-C4	89.59 (15)	C4-Re1-N2	82.12 (12)
C1-Re1-C4	175.01 (14)	N1-Re1-N2	75.63 (11)
C3-Re1-N1	175.53 (13)	C13-N1-Re1	111.7 (2)
C2-Re1-N1	98.32 (13)	C14-N2-Re1	110.8 (2)

H atoms were inserted at calculated positions (0.93–0.96 Å) and constrained with isotropic displacement parameters $[U_{iso}(H) = 1.2U_{eq}(C)]$.

Data collection: *CAD-4 EXPRESS* (Enraf–Nonius, 1994); cell refinement: *CAD-4 EXPRESS*; data reduction: *XCAD4* (Harms & Wocadlo, 1995); program(s) used to solve structure: *SIR2002* (Burla *et al.*, 2003); program(s) used to refine structure: *SHELXL97* (Sheldrick, 1997); molecular graphics: *ORTEP-3 for Windows* (Farrugia, 1997); software used to prepare material for publication: *WinGX* (Farrugia, 1999).

We thank the Wichita State Office of Research Administration, the Department of Energy and Parker Fellowships (JMV and SRV) for support.

References

- Burla, M. C., Camalli, M., Carrozzini, B., Cascarano, G., Giacovazzo, C., Polidori, G. & Spagna, R. (2003). J. Appl. Cryst. 36, 1103.
- Enraf-Nonius (1994). CAD-4 EXPRESS. Enraf-Nonius, Delft, The Netherlands
- Farrugia, L. J. (1997). J. Appl. Cryst. 30, 565.
- Farrugia, L. J. (1999). J. Appl. Cryst. 32, 837–838.
- Harms, K. & Wocadlo, S. (1995). XCAD4. University of Marburg, Germany.
- Shaver, R. J. & Rillema, D. P. (1992). Inorg. Chem. 31, 4101-4107.
- Sheldrick, G. M. (1997). SHELXL97. University of Göttingen, Germany.
- Walker, N. & Stuart, D. (1983). Acta Cryst. A39, 158-166.
- Wrighton, M. & Morse, D. L. (1974). J. Am. Chem. Soc. 96, 998-1003.